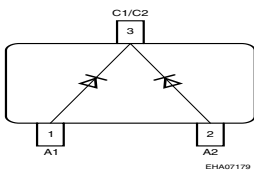
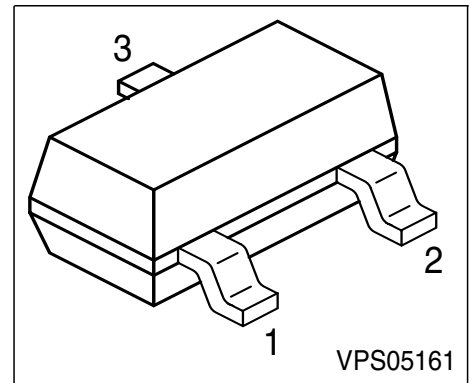


Silicon PIN Diode Array
Preliminary data

- Common cathode
- High power
- Low impedance



Type	Marking	Ordering Code	Pin Configuration			Package
			1=A1	2=A2	3=C1/C2	
BAR 68-05	PTs	upon request	1=A1	2=A2	3=C1/C2	SOT-23

Maximum Ratings

Parameter	Symbol	Value	Unit
Diode reverse voltage	V_R	50	V
Forward current	I_F	100	mA
Total power dissipation, $T_S = \text{tbd}$	P_{tot}	250	mW
Operating temperature range	T_{op}	-55 ... 150	°C
Storage temperature	T_{stg}	-55 ... 150	

Thermal Resistance

Junction - ambient ¹⁾	R_{thJA}	≤ tbd	K/W
Junction - soldering point	R_{thJS}	≤ tbd	

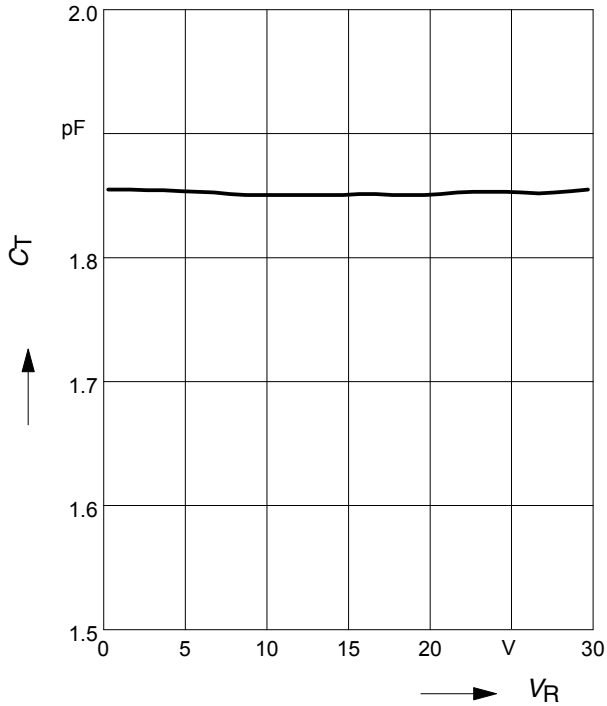
1) Package mounted on alumina 15mm x 16.7mm x 0.7mm

Electrical Characteristics at $T_A = 25\text{ }^\circ\text{C}$, unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC characteristics					
Breakdown voltage $I_{(BR)} = 5\text{ }\mu\text{A}$	$V_{(BR)}$	50	-	-	V
Reverse current $V_R = 30\text{ V}$	I_R	-	-	10	nA
Forward voltage $I_F = 50\text{ mA}$	V_F	-	0.815	1	V
AC Characteristics					
Diode capacitance $V_R = 5\text{ V}, f = 1\text{ MHz}$ $V_R = 20\text{ V}, f = 1\text{ MHz}$ $V_R = 0\text{ V}, f = 100\text{ MHz}$	C_T	-	1.9	-	pF
Forward resistance $I_F = 1\text{ mA}, f = 100\text{ MHz}$ $I_F = 10\text{ mA}, f = 100\text{ MHz}$	r_f	-	1.2	-	Ω
Charge carrier life time $I_F = 10\text{ mA}, I_R = 6\text{ mA}, I_R = 3\text{ mA}$	τ_{rr}	-	2.2	-	μs
Series inductance	L_S	-	1.8	-	nH
Intrinsic zone thickness	w	-	25	-	μm

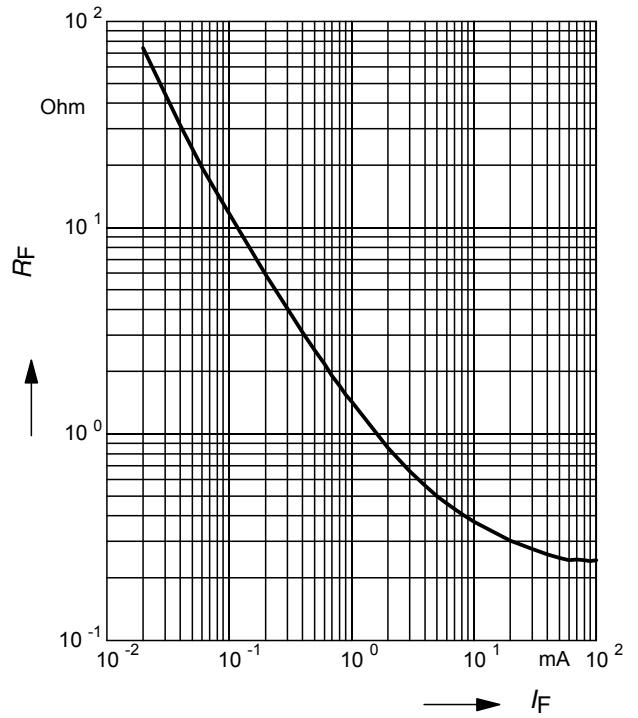
Diode capacitance $C_T = f(V_R)$

$f = 1\text{MHz}$



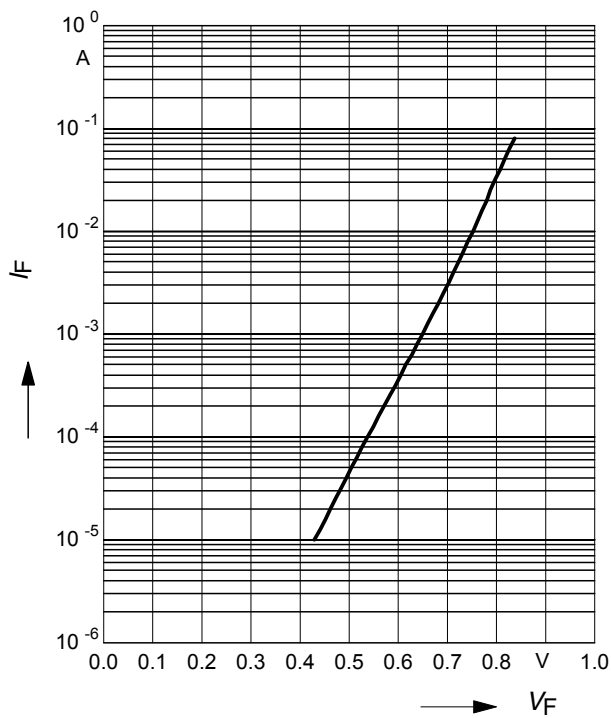
Forward resistance $r_f = f(I_F)$

$f = 100\text{MHz}$



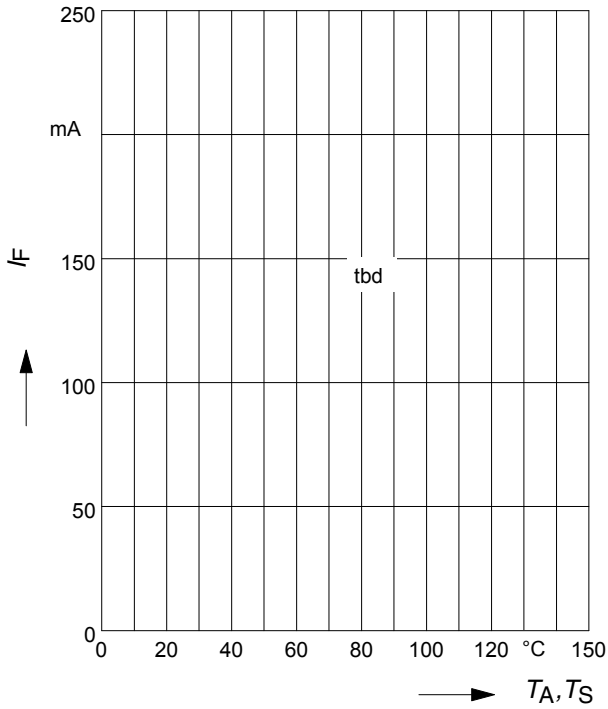
Forward current $I_F = f(V_F)$

$T_A = 25^\circ\text{C}$

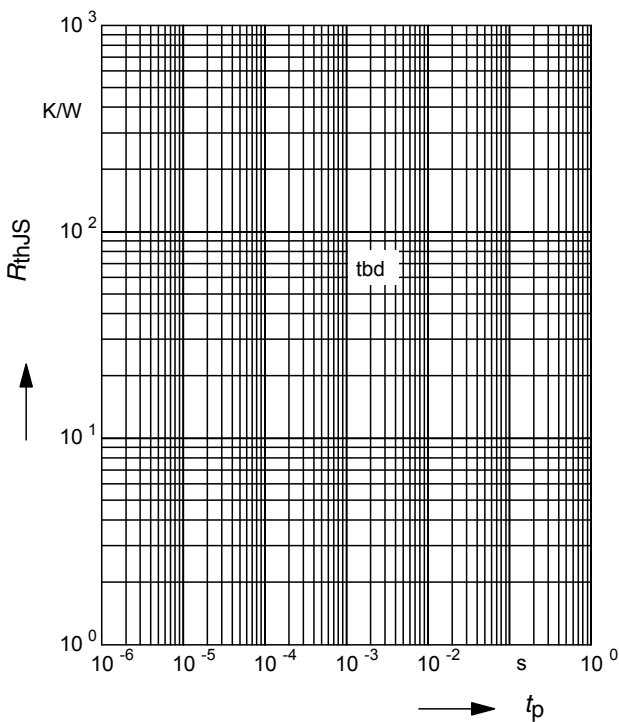


Forward current $I_F = f(T_A^*; T_S)$

*) : mounted on alumina 15mm x 16.7mm x 0.7mm



Permissible Pulse Load $R_{thJS} = f(t_p)$



Permissible Pulse Load

$I_{Fmax} / I_{FDC} = f(t_p)$

